 e <i>arcn N</i> otes ::::::::::::::::::::::::::::::::::::			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/025,531	ESTEVEZ ET AL.
Examiner	Art Unit
Amir Alavi	2621

SEARCHED				
Class	Subclass	Date	Examiner	
382	172,218, 232,233, 235,236, 239	5/4/2005	A.A.	
382	250	5/4/2005	A.A.	
375	240.05	5/4/2005	A.A.	
375	240.07	5/4/2005	A.A.	
375	240.13	5/4/2005	A.A.	
375	240.2	5/4/2005	A.A.	
348	231.2	5/4/2005	Ą.A.	
348	372	5/4/2005	A.A.	
709	247,253	5/4/2005	A.A.	
386	46	5/4/2005	A.A.	
ABOVE	UPLATES	10/20105	·羌.凡	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East & IEEE	5/4/2005	A.A.		
ABove uplated	10/20/05	A.A.		
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